Dial Channel, 14-Bit, 65 MSPS A/D Converter with Analog Input Signal Conditioning

AD13465

FEATURES

Dual, 65 MSPS Minimum Sample Rate Channel-to-Channel Matching, ±1% Gain Error 90 dB Channel-to-Channel Isolation DC-Coupled Signal Conditioning
85 dB Spurious-Free Dynamic Range Selectable Bipolar Inputs (±1 V and ±0.5 V Ranges) Integral Two-Pole Low-Pass Nyquist Filter Two's Complement Output Format
3.3 V Compatible Outputs
1.8 W per Channel Industrial and Military Grade

APPLICATIONS

Radar Processing Optimized for I/Q Baseband Operation Phased Array Receivers Multichannel, Multimode Receivers GPS Antijamming Receivers Communications Receivers

PRODUCT DESCRIPTION

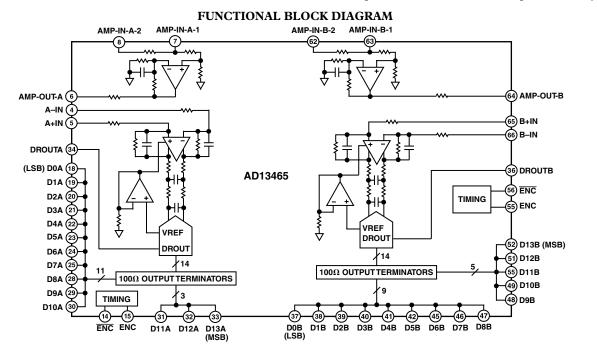
The AD13465 is a complete dual channel signal processing solution including on-board amplifiers, references, ADCs, and output termination components to provide optimized system performance. The AD13465 has on-chip track-and-hold circuitry and utilizes an innovative multipass architecture to achieve 14-bit, 65 MSPS performance. The AD13465 uses state-of-the-art high-density circuit design and laser-trimmed thin-film resistor networks to achieve exceptional channel matching and impedance control, and provide for significant board area savings.

Multiple options are provided for driving the analog input, including single-ended, differential, and optional series filtering. The AD13465 also offers the user a choice of analog input signal ranges to further minimize additional external signal conditioning, while remaining general-purpose. The AD13465 operates with ± 5.0 V for the analog signal conditioning, 5.0 V supply for the analog-to-digital conversion, and 3.3 V digital supply for the output stage. Each channel is completely independent, allowing operation with independent Encode and Analog Inputs, while maintaining minimal crosstalk and interference.

The AD13465 is packaged in a 68-lead ceramic gull wing package. Manufacturing is done on Analog Devices' MIL-38534 Qualified Manufacturers Line (QML) and components are available up to Class-H (-40°C to +85°C). The components are manufactured using Analog Devices' high-speed complementary bipolar process (XFCB).

PRODUCT HIGHLIGHTS

- 1. Guaranteed sample rate of 65 MSPS.
- 2. Input signal conditioning included; gain and impedance matching.
- 3. Single-ended, differential, or off-module filter options.
- 4. Fully tested/characterized full channel performance
- 5. Pin compatible with 12-bit AD13280 product family.



REV.0

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$\label{eq:AD13465} AD13465 - TARGET \ SPECIFICATIONS \ ^{(AV_{CC}\ =\ 5\ V;\ AV_{EE}\ =\ -5\ V;\ DV_{CC}\ =\ 3.3\ V \ applies \ to \ each \ ADC \ with \ Front \ End \ Amplifier \ unless \ otherwise \ noted.)$

Parameter	Temp	Test Level	Mil Sub- Group	A Min	AD13465AZ/E Typ	BZ Max	Unit
RESOLUTION				14			Bits
DC ACCURACY							
No Missing Codes	Full	IV	12		Guaranteed		
Offset Error	25°C	I	1	-2.2	± 0.2	+2.2	% FS
	Full	VI	2, 3	-2.2	± 1.0	+2.2	% FS
Offset Error Channel Match	Full	VI	1, 2, 3	-1.0	± 0.1	+1.0	% FS
Gain Error ¹	25°C	I	1	-3.0	-1.0	+1.0	% FS
	Full	VI	2, 3	-5.0	± 2.0	+5.0	% FS
Gain Error Channel Match	25°C	I	1	+1.5	± 0.5	+1.5	% FS
	Max	VI	2	-3.0	± 1.0	+3.0	% FS
	Min	VI	3	-5.0	± 1.0	+5.0	% FS
SINGLE-ENDED ANALOG INPUT							
Input Voltage Range							
AMP-IN-X-1	Full	v			±0.5		v
AMP-IN-X-1 AMP-IN-X-2	Full	V			± 0.3 ± 1.0		V V
Input Resistance	I'ull	v			±1.0		v
AMP-IN-X-1	Full	IV	12	99	100	101	Ω
AMP-IN-X-1 AMP-IN-X-2	Full	IV	12	198	200	202	Ω
Input Capacitance ²	Full	11	12	190	200 4.0	7.0	pF
Analog Input Bandwidth ³	Full	v			4.0	7.0	MHz
	Full	v			100		MITZ
DIFFERENTIAL ANALOG INPUT							
Analog Signal Input Range							
A+IN to A–IN and B+IN to B–IN ⁴	Full	V			± 1.0		V
Input Impedance	Full	V			618		Ω
Analog Input Bandwidth ³	Full	V			50		MHz
ENCODE INPUT (ENC, ENC) ⁵							
Differential Input Voltage	Full	IV	12	0.4			V p-p
Differential Input Resistance	25°C	v			10		kΩ
Differential Input Capacitance	25°C	V			2.5		pF
SWITCHING PERFORMANCE							
Maximum Conversion Rate ⁶	Full	VI	4, 5, 6	65			MSPS
Minimum Conversion Rate ⁶	Full	IV	12	05		20	MSPS
Aperture Delay (t_A)	25°C	V	12		1.5	20	ns
Aperture Delay Matching	25°C	IV	12		250	500	ps
Aperture Uncertainty (Jitter)	25°C	V	12		0.3	500	ps ps rm
ENCODE Pulse with High	25°C	IV	12	5.0	0.5 7.7	9.5	ns
ENCODE Pulse with Low	25°C	IV	12	5.0	7.7	9.5 9.5	ns
Output Delay (t_{OD})	Full	IV	12	5.0	7.5	9.5	ns
Encode, Rising to Data Ready,	Full	V	12		11.5		ns
Rising Delay	1 un	v			11.5		115
SNR ⁷							1000
Analog Input @ 4.98 MHz	25°C	V			72		dBFS
Analog Input @ 9.9 MHz	25°C	I	4	70	72		dBFS
	Full	II	5,6	69	71		dBFS
Analog Input @ 21 MHz	25°C	I	4	69	71		dBFS
	Full	II	5,6	68	70		dBFS
Analog Input @ 32 MHz	25°C	V			70		dBFS
	Full	V			69		dBFS
SINAD ⁸							
Analog Input @ 4.98 MHz	25°C	V			72		dBFS
Analog Input @ 9.9 MHz	25°C	I	4	69	72		dBFS
	Full	II	5,6	68.5	70.5		dBFS
Analog Input @ 21 MHz	25°C	I	4	66.5	70		dBFS
	Full	II	5,6	66	69		dBFS
Analog Input @ 32 MHz	25°C	V			63		dBFS
	Full	v			61		dBFS

		Test	Mil Sub-	AD13465AZ/BZ			
Parameter	Temp	Level	Group	Min	Тур	Max	Unit
SPURIOUS-FREE DYNAMIC RANGE ⁹							
Analog Input @ 4.98 MHz	25°C	V			85		dBFS
Analog Input @ 9.9 MHz	25°C	I	4	80	86		dBFS
	Full	II	5,6	78	84		dBFS
Analog Input @ 21 MHz	25°C	I	4	70	76		dBFS
	Full	II	5,6	69	74		dBFS
Analog Input @ 32 MHz	25°C	V			63		dBFS
	Full	V			62		dBFS
SINGLE-ENDED ANALOG INPUT							
Pass Band Ripple to 10 MHz	25°C	V			0.05		dB
Pass Band Ripple to 25 MHz	25°C	V			0.1		dB
DIFFERENTIAL ANALOG INPUT							
Pass Band Ripple to 10 MHz	25°C	v			0.3		dB
Pass Band Ripple to 25 MHz	25°C	V			0.82		dB
TWO-TONE IMD REJECTION ¹⁰							
$f_{IN} = 9.1 \text{ MHz} \text{ and } 10.1 \text{ MHz}$	25°C	I	4	77.5	82		dBc
f_{1N} = 5.1 for f_{1} and f_{2} are -7 dB	Full	II	5,6	76.5	80		uDe
$f_{IN} = 19.1 \text{ MHz}$ and 20.7 MHz	25°C	V	- , -		72		dBc
f_1 and f_2 are -7 dB							
CHANNEL-TO-CHANNEL ISOLATION ¹¹	25°C	IV	12	90			dB
TRANSIENT RESPONSE	25°C	V			15.3		ns
DIGITAL OUTPUTS ¹²							
Logic Compatibility					CMOS		
$DV_{CC} = 3.3 V$							
Logic 1 Voltage	Full	I	1, 2, 3	2.5	DVCC -		V
Logic 0 Voltage	Full	I	1, 2, 3		0.2	0.5	V
$DV_{CC} = 5 V$							
Logic 1 Voltage	Full	V			DVCC -	- 0.3	V
Logic 0 Voltage	Full	V		0.35 Two's Complement		V	
Output Coding				1 WC	's Complem	ent	
POWER SUPPLY							
AV _{CC} Supply Voltage ¹³	Full	VI		4.85	5.0	5.25	V
I (AV _{CC}) Current	Full	V			270	308	mA
AV_{EE} Supply Voltage ¹³	Full	VI		-5.25	-5.0	-4.75	V
I (AV _{EE}) Current DV Supply Valtage ¹³	Full			2 125	38	49	mA
DV_{CC} Supply Voltage ¹³	Full	VI		3.135	3.3	3.465	V
I (DV _{CC}) Current (Total) Supply Current per Channel	Full Full		1, 2, 3		34 369	46 403	mA mA
Power Dissipation (Total)	Full	I	1, 2, 3		3.57	403 3.9	W
Power Supply Rejection Ratio (PSRR)	Full	V	1, 2, 5		0.02	5.7	% FSR/
2 out oupping resolution rulio (1 or (1)		'			0.02		% V _S

NOTES

¹Gain tests are performed on AMP-IN-X-1 input voltage range.

²Input capacitance spec. combines AD8037 capacitance and ceramic package capacitance.

³Full Power Bandwidth is the frequency at which the spectral power of the fundamental frequency (as determined by FFT analysis) is reduced by 3 dB.

⁴For differential input: +IN = 1 V p-p and -IN = 1 V p-p (signals are 180° out of phase). For single ended input: +IN = 2 V p-p and -IN = GND.

⁵All AC specifications tested by driving ENCODE and ENCODE differentially. AMP-IN-X-1 = 1 V p-p, AMP-IN-X-2 = GND.

 6 Minimum and Maximum conversion rates allow for variation in Encode Duty Cycle of 50% \pm 5%.

⁷Analog Input signal power at -1 dBFS; signal-to-noise ratio (SNR) is the ratio of signal level to total noise (first five harmonics removed).

Encode = 65 MSPS. SNR is reported in dBFS, related back to converter full scale.

⁸Analog Input signal power at –1 dBFS; signal-to-noise and distortion (SINAD) is the ratio of signal level to total noise + harmonics.

Encode = 65 MSPS. SINAD is reported in dBFS, related back to converter full scale.

 9 Analog Input signal power at -1 dBFS; SFDR is ratio of converter full scale to worst spur.

¹⁰Both input tones at -7 dBFS; two tone intermodulation distortion (IMD) rejection is the ratio of either tone to the worst third order intermod product.

¹¹Channel-to-channel isolation tested with A Channel grounded and a full-scale signal applied to B Channel.

¹²Digital output logic levels: $DV_{CC} = 3.3 \text{ V}$, $C_{LOAD} = 10 \text{ pF}$. Capacitive loads > 10 pF will degrade performance.

¹³Supply voltage recommended operating range. AV_{CC} may be varied from 4.85 V to 5.25 V. However, rated ac (harmonics) performance is valid only over the range $AV_{CC} = 5.0$ V to 5.25 V.

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS¹

ELECTRICAL
AV _{CC} Voltage 0 V to 7 V
AV_{EE} Voltage
DV _{CC} Voltage 0 V to 7 V
Analog Input Voltage $\dots \dots \dots$
Analog Input Current
Digital Input Voltage (ENCODE) 0 to V _{CC}
ENCODE, ENCODE Differential Voltage
Digital Output Current10 mA to +10 mA
ENVIRONMENTAL ²
Operating Temperature (Case)40°C to +85°C
Maximum Junction Temperature 175°C
Lead Temperature (Soldering, 10 sec) 300°C
Storage Temperature Range (Ambient)65°C to +150°C
NOTES
1 About the manimum matings are limiting as loss and in dividually and have a

¹ Absolute maximum ratings are limiting values applied individually, and beyond which the serviceability of the circuit may be impaired. Functional operability is not necessarily implied. Exposure to absolute maximum rating conditions for an extended period of time may affect device reliability.

 2 Typical thermal impedance for "ES" package: $\theta_{JC},$ 2.2°C/W; $\theta_{JA},$ 24.3°C/W.

TEST LEVEL

- I 100% Production Tested.
- II 100% Production Tested at 25°C, and sample tested at specified temperatures. AC testing done on sample basis.
- III Sample Tested Only.
- IV Parameter is guaranteed by design and characterization testing.
- V Parameter is a typical value only.
- VI 100% production tested at temperature at 25°C: sample tested at temperature extremes.

CAUTION_

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD13465 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



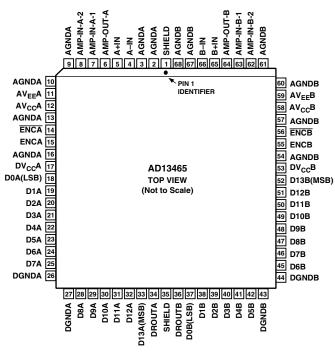
ORDERING GUIDE

Model	Temperature Range (Case)	Package Description	Package Option
AD13465AZ	-25°C to +85°C	68-Lead Ceramic Leaded Chip Carrier	ES-68C
AD13465AF	–25°C to +85°C	68-Lead Ceramic Leaded Chip Carrier with Nonconductive Tie-Bar	ES-68C
5962-0150601HXA AD13465/PCB	-40°C to +85°C 25°C	68-Lead Ceramic Leaded Chip Carrier Evaluation Board with AD13465AZ	ES-68C

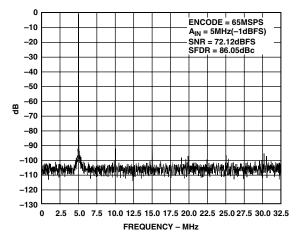
PIN FUNCTION DESCRIPTIONS

Pin No.	Mnemonic	Function		
1, 35	SHIELD	Internal Ground Shield Between Channels.		
2, 3, 9, 10, 13, 16	AGNDA	A Channel Analog Ground. A and B grounds should be connected as close to the device as possible.		
4	A–IN	Inverting Differential Input (Gain = 1).		
5	A+IN	Noninverting Differential Input (Gain = 1).		
6	AMP-OUT-A	Single-Ended Amplifier Output (Gain = 2).		
7	AMP-IN-A-1	Analog Input for A Side ADC (Nominally ± 0.5 V).		
8	AMP-IN-A-2	Analog Input for A Side ADC (Nominally ± 1.0 V).		
11	AV _{EE} A	A Channel Analog Negative Supply Voltage (Nominally –5.0 V or –5.2 V).		
12	AV _{CC} A	A Channel Analog Positive Supply Voltage (Nominally 5.0 V).		
14	ENCA	Complement of Encode; Differential Input.		
15	ENCA	Encode Input; Conversion Initiated on Rising Edge.		
17	DV _{CC} A	A Channel Digital Positive Supply Voltage (Nominally 5.0 V/3.3 V).		
18–25, 28–33	D0A–D13A	Digital Outputs for ADC A. D0 (LSB).		
26, 27	DGNDA	A Channel Digital Ground.		
34	DROUTA	Data Ready A Output.		
36	DROUTB	Data Ready B Output.		
37-42, 45-52	D0B-D13B	Digital Outputs for ADC B. D0 (LSB).		
43, 44	DGNDB	B Channel Digital Ground.		
53	DV _{CC} B	B Channel Digital Positive Supply Voltage (Nominally 5.0 V/3.3 V).		
54, 57, 60, 61, 67, 68	AGNDB	B Channel Analog Ground.		
55	ENCB	Encode Input; Conversion Initiated on Rising Edge.		
56	ENCB	Complement of Encode; Differential Input.		
58	AV _{CC} B	B Channel Analog Positive Supply Voltage (Nominally 5.0 V).		
59	AV _{EE} B	B Channel Analog Negative Supply Voltage (Nominally -5.0 V or -5.2 V).		
62	AMP-IN-B-2	Analog Input for B Side ADC (Nominally ± 1.0 V).		
63	AMP-IN-B-1	Analog Input for B Side ADC (Nominally ± 0.5 V).		
64	AMP-OUT-B	Single-Ended Amplifier Output (Gain = 2).		
65	B+IN	Noninverting Differential Input (Gain = 1).		
66	B–IN	Inverting Differential Input (Gain = 1).		

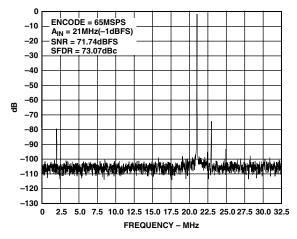
PIN CONFIGURATION



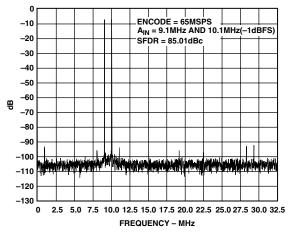
AD13465–Typical Performance Characteristics



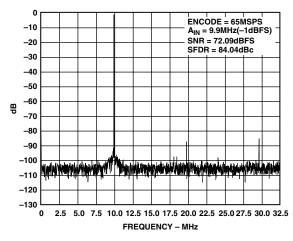
TPC 1. Single Tone @ 5 MHz



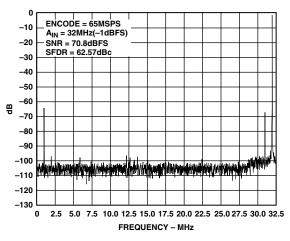
TPC 2. Single Tone @ 21 MHz

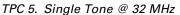


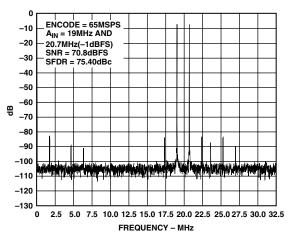
TPC 3. Two-Tone @ 9.1 MHz/10.1 MHz



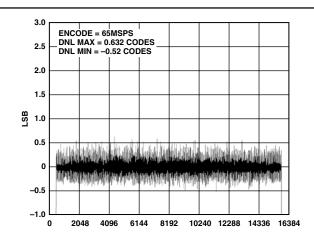
TPC 4. Single Tone @ 9.9 MHz

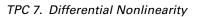


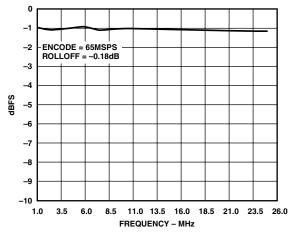




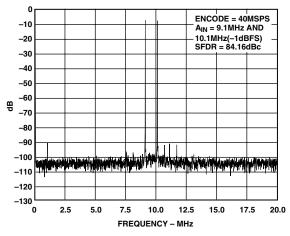
TPC 6. Two-Tone @ 19 MHz/20.7 MHz



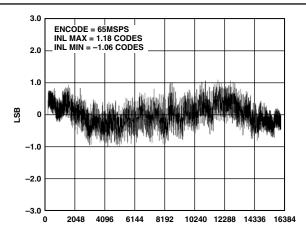




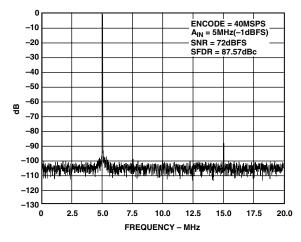




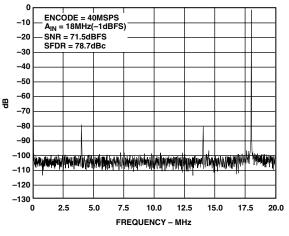
TPC 9. Two-Tone @ 9.1 MHz/10.1 MHz



TPC 10. Integral Nonlinearity



TPC 11. Single Tone @ 5 MHz



TPC 12. Single Tone @ 18 MHz

DEFINITION OF SPECIFICATIONS

Analog Bandwidth

The analog input frequency at which the spectral power of the fundamental frequency (as determined by the FFT analysis) is reduced by 3 dB.

Aperture Delay

The delay between a differential crossing of ENCODE and $\overline{\text{ENCODE}}$ command and the instant at which the analog input is sampled.

Aperture Uncertainty (Jitter)

The sample-to-sample variation in aperture delay.

Differential Analog Input Resistance, Differential Analog Input Capacitance, and Differential Analog Input Impedance The real and complex impedances measured at each analog input port. The resistance is measured statically and the capacitance and differential input impedances are measured with a network analyzer.

Differential Analog Input Voltage Range

The peak-to-peak differential voltage that must be applied to the converter to generate a full-scale response. Peak differential voltage is computed by observing the voltage from the other pin, which is 180 degrees out of phase. Peak-to-peak differential is computed by rotating the inputs phase 180 degrees and taking the peak measurement again. The difference is then computed between both peak measurements.

Differential Nonlinearity

The deviation of any code from an ideal 1 LSB step.

Encode Pulsewidth/Duty Cycle

Pulsewidth high is the minimum amount of time that the ENCODE pulse should be left in Logic 1 state to achieve rated performance; pulsewidth low is the minimum time ENCODE pulse should be left in low state. At a given clock rate, these specs define an acceptable encode duty cycle.

Harmonic Distortion

The ratio of the rms signal amplitude to the rms value of the worst harmonic component.

Integral Nonlinearity

The deviation of the transfer function from a reference line measured in fractions of 1 LSB using a "best straight line" determined by a least square curve fit.

Minimum Conversion Rate

The encode rate at which the SNR of the lowest analog signal frequency drops by no more than 3 dB below the guaranteed limit.

Maximum Conversion Rate

The encode rate at which parametric testing is performed.

Output Propagation Delay

The delay between a differential crossing of ENCODE and $\overline{\text{ENCODE}}$ command and the time when all output data bits are within valid logic levels.

Overvoltage Recovery Time

The amount of time required for the converter to recover to 0.02% accuracy after an analog input signal of the specified percentage of full scale is reduced to midscale.

Power Supply Rejection Ratio

The ratio of a change in input offset voltage to a change in power supply voltage.

Signal-to-Noise-and-Distortion (SINAD)

The ratio of the rms signal amplitude (set at 1 dB below full scale) to the rms value of the sum of all other spectral components, including harmonics but excluding dc. May be reported in dB (i.e., degrades as signal level is lowered) or in dBFS (always related back to converter full scale).

Signal-to-Noise Ratio (without Harmonics)

The ratio of the rms signal amplitude (set at 1 dB below full scale) to the rms value of the sum of all other spectral components, excluding the first five harmonics and dc. May be reported in dB (i.e., degrades as signal level is lowered) or in dBFS (always related back to converter full scale).

Spurious-Free Dynamic Range

The ratio of the rms signal amplitude to the rms value of the peak spurious spectral component. The peak spurious component may or may not be a harmonic.

Transient Response

The time required for the converter to achieve 0.02% accuracy when a one-half full-scale step function is applied to the analog input.

Two-Tone Intermodulation Distortion Rejection

The ratio of the rms value of either input tone to the rms value of the worst third order intermodulation product; reported in dBc.

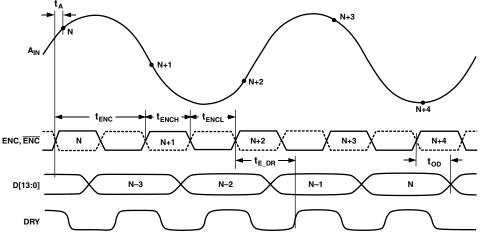


Figure 1. Timing Diagram

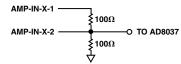


Figure 2. Single-Ended Input Stage

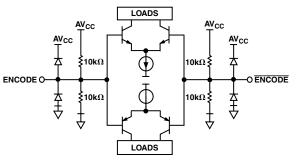


Figure 3. ENCODE Inputs

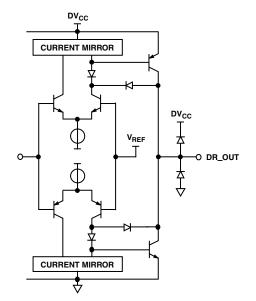


Figure 4. Digital Output Stage

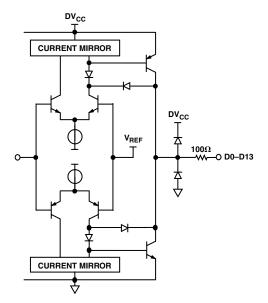


Figure 5. Digital Output Stage

THEORY OF OPERATION

The AD13465 is a high-dynamic range, 14-bit, 65 MHz pipeline delay (three pipelines) analog-to-digital converter. The custom analog input section provides input ranges of 1 V p-p and 2 V p-p, and input impedance configurations of 50 Ω , 100 Ω , and 200 Ω .

The AD13465 employs four monolithic ADI components per channel (AD8037, AD8138, AD8031, and AD6644), along with multiple passive resistor networks and decoupling capacitors to fully integrate a complete 14-bit analog-to-digital converter.

In the single-ended input configuration, the input signal is passed through a precision laser trimmed resistor divider allowing the user to externally select operation with a full-scale signal of ± 0.5 V or ± 1.0 V by choosing the proper input terminal for the application. The result of the resistor divider is to apply a full-scale input approximately 0.4 V to the noninverting input of the internal AD8037 amplifier.

The AD13465 analog input includes an AD8037 amplifier featuring an innovative architecture that maximizes the dynamic range capability on the amplifier's inputs and outputs. The AD8037 amplifier provides a high-input impedance and gain for driving the AD8138 in a single-ended-to-differential amplifier configuration. The AD8138 has a -3 dB bandwidth at 300 MHz and delivers a differential signal with the lowest harmonic distortion available in a differential amplifier. The AD8138 differential outputs help balance the differential inputs to the AD6644 maximizing the performance of the device.

The AD8031 provides the buffer for the internal reference analog-to-digital converter. The internal reference voltage of the AD6644 is designed to track the offsets and drifts and is used to ensure matching over an extended temperature range of operation. The reference voltage is connected to the output common mode input on the AD8138. This reference voltage sets the output common mode on the AD8138 at 2.4 V, which is the midsupply level for the ADC.

The AD6644 has complementary analog input pins, AIN and AIN. Each analog input is centered at 2.4 V and should swing ± 0.55 V around this reference. Since AIN and AIN are 180 degrees out of phase, the differential analog input signal is 2.2 V peak-to-peak. Both analog inputs are buffered prior to the first track-and-hold.

The AD6644 digital outputs drive 100Ω series resistors (Figure 5.) The result is a 14-bit parallel digital CMOS-compatible word, coded as two's complement.

USING THE SINGLE-ENDED INPUT

The AD13465 has been designed with the user's ease of operation in mind. Multiple input configurations have been included on board to allow the user a choice of input signal levels and input impedance. The standard inputs are ± 0.5 V and ± 1.0 V. The user can select the input impedance of the AD13465 on any input by using the other inputs as alternate locations for the GND. The following chart summarizes the impedance options available at each input location.

AMP-IN-X-1 = 100 Ω when AMP-IN-X-2 is open. AMP-IN-X-1 = 50 Ω when AMP-IN-X-2 is shorted to GND. AMP-IN-X-2 = 200 Ω when AMP-IN-X-1 is open.

Each channel has two analog inputs AMP-IN-A-1 and AMP-IN-A-2 or AMP-IN-B-1 and AMP-IN-B-2. Use AMP-IN-A-1

or AMP-IN-B-1 when an input of ± 5 V full scale is desired. Use AMP-IN-A-2 or AMP-IN-B-2 when ± 1 V full scale is desired. Each channel has an AMP-OUT that must be tied to either a noninverting or inverting input of a differential amplifier with the remaining input grounded. For example, Side A, AMP-OUT-A (Pin 6) must be tied to A+IN (Pin 5) with A-IN (Pin 4) tied to ground for noninverting operation or AMP-OUT-A (Pin 6) tied to A-IN (Pin 4) with A+IN (Pin 5) tied to ground for inverting operation.

USING THE DIFFERENTIAL INPUT

Each channel of the AD13465 was designed with two optional differential inputs, A+IN, A-IN and B+IN, B-IN. The inputs provide system designers with the ability to bypass the AD8037 amplifier and drive the AD8138 directly. The AD8138 differential ADC driver can be deployed in either a single-ended or differential input configuration. The differential analog inputs have a nominal input impedance of $620 \ \Omega$ and nominal fullscale input range of 1.2 V p-p. The AD8138 amplifier drives a differential filter and the custom analog-to-digital converter. The differential input configuration provides the lowest even-order harmonics and signal-to-noise (SNR) performance improvement of up to 3 dB (SNR = 73 dBFS). Exceptional care was taken in the layout of the differential input signal paths. The differential input transmission line characteristics are matched and balanced. Equal attention to system level signal paths must be provided in order to realize significant performance improvements.

APPLYING THE AD13465

Encoding the AD13465

The AD13465 encode signal must be a high quality, extremely low phase noise source, to prevent degradation of performance. Maintaining 14-bit accuracy at 65 MSPS places a premium on encode clock phase noise. SNR performance can easily degrade 3 dB to 4 dB with 32 MHz input signals when using a high-jitter clock source. See Analog Devices' Application Note AN-501, "Aperture Uncertainty and ADC System Performance," for complete details. For optimum performance, the AD13465 must be clocked differentially. The encode signal is usually ac-coupled into the ENCODE and ENCODE pins via a transformer or capacitors. These pins are biased internally and require no additional bias.

Shown below is one preferred method for clocking the AD13465. The clock source (low jitter) is converted from single-ended to differential using an RF transformer. The back-to-back Schottky diodes across the transformer secondary limit clock excursions into the AD13465 to approximately 0.8 V p-p differential. This helps prevent the large voltage swings of the clock from feeding through to the other portions of the AD13465, and limits the noise presented to the ENCODE inputs. A crystal clock oscillator can also be used to drive the RF transformer if an appropriate limited resistor (typically 100 Ω) is placed in the series with the primary.

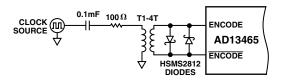


Figure 6. Crystal Clock Oscillator-Differential Encode

If a low jitter ECL/PECL clock is available, another option is to ac-couple a differential ECL/PECL signal to the encode input pins as shown below. A device that offers excellent jitter performance is the MC100LVEL16 (or same family) from Motorola.

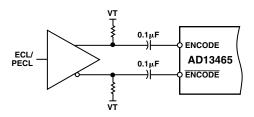


Figure 7. Differential ECL for Encode

Jitter Consideration

The signal-to-noise ratio (SNR) for any ADC can be predicted. When normalized to ADC codes, the equation below, accurately predicts the SNR based on three terms. These are jitter, average DNL error, and thermal noise. Each of these terms contributes to the noise within the converter.

$$SNR = -20 \times \log \left[\left(\frac{(1+\varepsilon)}{2^N} \right) + (2 \times \pi \times f_{ANALOG} \times t_{J RMS})^2 + \left(\frac{V_{NOISE RMS}}{2^N} \right)^2 \right]^{1/2}$$

 f_{ANALOG} = analog input frequency t_{LPMS} = rms jitter of the encode (rm

- $t_{J \text{ RMS}}$ = rms jitter of the encode (rms sum of encode source and internal encode circuitry)
- ϵ = average DNL of the ADC (typically 0.50 LSB)
- N = Number of bits in the ADC
- $V_{NOISE RMS}$ = V rms noise referred to the analog input of the ADC (typically 5 LSB)

For a 14-bit analog-to-digital converter like the AD13465, aperture jitter can greatly affect the SNR performance as the analog frequency is increased. The chart below shows a family of curves that demonstrates the expected SNR performance of the AD13465 as jitter increases. The chart is derived from the above equation.

For a complete discussion of aperture jitter, please consult Analog Devices' Application Note AN-501, "Aperture Uncertainty and ADC System Performance."

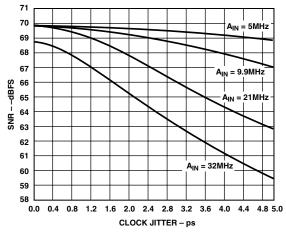


Figure 8. SNR vs. Jitter

Power Supplies

Care should be taken when selecting a power source. Linear supplies are strongly recommended. Switching supplies tend to have radiated components that may be *received* by the AD13465. Each of the power supply pins should be decoupled as closely to the package as possible, using 0.1 μ F chip capacitors.

The AD13465 has separate digital and analog power supply pins. The analog supplies are denoted AV_{CC} and the digital supply pins are denoted DV_{CC} . AV_{CC} and DV_{CC} should be separate power supplies. This is because the fast digital output swings can couple switching current back into the analog supplies. Note that AV_{CC} must be held within +5% and -3% of 5 V. The AD13465 is specified for DV_{CC} = 3.3 V as this is a common supply for digital ASICs.

Output Loading

Care must be taken when designing the data receivers for the AD13465. The digital outputs drive an internal series resistor (e.g., 100 Ω) followed by a gate like 75LCX574. To minimize capacitive loading, there should be only one gate on each output pin. An example of this is shown in the evaluation board schematic shown in Figure 10. The digital outputs of the AD13465 have a constant output slew rate of 1 V/ns. A typical CMOS gate combined with a PCB trace will have a load of approximately 10 pF. Therefore, as each bit switches, 10 mA (10 $pF \times 1 V \div 1 ns$) of dynamic current per bit will flow in or out of the device. A fullscale transition can cause up to 140 mA (14 bits \times 10 mA/bit) of transient current through the output stages. These switching currents are confined between ground and the $\mathrm{DV}_{\mathrm{CC}}$ pin. Standard TTL gates should be avoided since they can appreciably add to the dynamic switching currents of the AD13465. It should also be noted that extra capacitive loading will increase output timing and invalidate timing specifications. Digital output timing is guaranteed with 10 pF loads.

LAYOUT INFORMATION

The schematic of the evaluation board (Figure 10) represents a typical implementation of the AD13465. The pinout of the AD13465 is very straightforward and facilitates ease of use and the implementation of high frequency/high resolution design practices. It is recommended that high quality ceramic chip capacitors be used to decouple each supply pin to ground directly at the device. All capacitors can be standard high quality ceramic chip capacitors.

Care should be taken when placing the digital output runs. Because the digital outputs have such a high slew rate, the capacitive loading on the digital outputs should be minimized. Circuit traces for the digital outputs should be kept short and connect directly to the receiving gate. Internal circuitry buffers the outputs of the ADC through a resistor network to eliminate the need to externally isolate the device from the receiving gate.

EVALUATION BOARD

The AD13465 evaluation board (Figure 9) is designed to provide optimal performance for evaluation of the AD13465 analog-to-digital converter. The board encompasses everything needed to ensure the highest level of performance for evaluating the AD13465. The board requires an analog input signal, encode clock, and power supply inputs. The clock is buffered on-board to provide clocks for the latches. The digital outputs and out clocks are available at the standard 40-pin connectors J1 and J2.

Power to the analog supply pins is connected via banana jacks. The analog supply powers the associated components and the analog section of the AD13465. The digital outputs of the AD13465 are powered via banana jacks with 3.3 V. Contact the factory if additional layout or applications assistance is required.

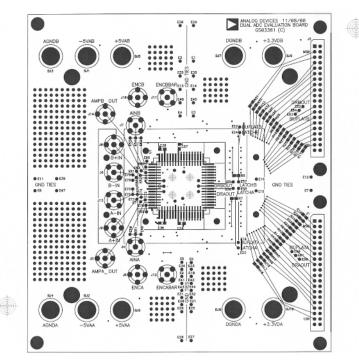


Figure 9. Evaluation Board Mechanical Layout

Bill of Materials List for Evaluation Board

Qty	Component Name	Ref/Des	Value	Description	Manufacturing Part No.
2	74CLX16373MTD	U7, U8		Latch	74LCX1673MTD (Fairchild)
1	AD13465AZ	U1		AD13465AZ	AD13465AZ
2	ADP3330	U5, U6		Regulator	ADP3330ART-3.3RL7
10	BJACK	BJ1-BJ10		Banana Jacks	108-0740-001 (Johnson Components)
2	BRES0805	R41, R53	25 Ω	0805 SM Resistor	EFJ-6GEYJ240V
4	BRES0805	R38, R39, R55, R56	33 kΩ	0805 SM Resistor	EFJ-6GEYJ333V
6	RES2	R1, R2, R5, R7, R8	50 Ω	0805 SM Resistor	EFJ-6GEYJ333V
		R54			
36	RES2	R3, R4, R6, R9	100 Ω	0805 SM Resistor	EFJ-6GEYJ333V
		R12–R15, R19–R28,			
		R31–R36, R37,			
		R42–R46, R51, R52			
28	CAP2	C1, C2, C5–C10,	0.1 µF	0805 SM Resistor	GRM 40X7R104K025BL
		C12, C16–C18			
		C20–C26, C28			
		C30–C38			
2	CAP2	C13, C27	0.47 μF	0805 SM Resistor	VJ1206U474MFXMB
2	H40DM	J1, J2		2×20 40-Pin Male Connector	TSW-120-08-G-D
6	IND2	L1–L6	47Ω	SM Inductor	2743019447
4	MC10EL16	U2, U3, U9, U11		Clock Drivers	MC1016EP16D
2	MC100ELT23	U4, U10		ECL/TTL Clock Drivers	SY100ELT23L
8	POLCAP2	C3, C4, C11, C14,	10 µF	Tantalum Polar Caps	T491C106M016A57280
		C15, C19, C29, C30			
4	RES2	R47–R50	0 Ω	0805 SM Resistor	ERJ-6GEY OR 00V
12	SMA	J3–J14		SMA Connectors	142-0701-201
4	Stand-Off			Stand-Off	313-2477-016 (Johnson Components)
4	Screws			Screws (Stand-Off)	MPMS 004 0005 PH (Building Fasteners)
1	PCB			AD13465 Eval Board (Rev B)	GS03361

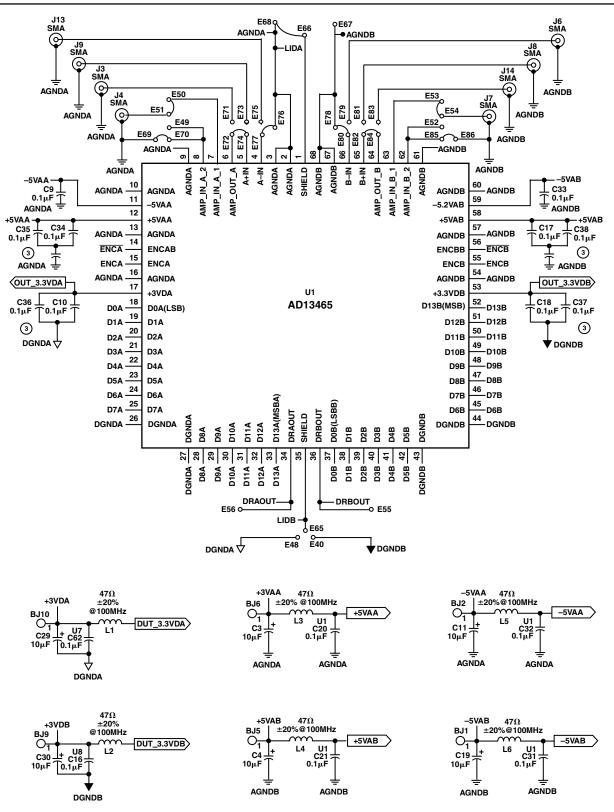


Figure 10a. Evaluation Board

U8 R47 0Ω H40DM LF2 OF2 24 DGNDA R18, DNI 25 J1 F0A F17, DNI F1A 115 015 4 23 26 40 \sim 114 014 3.3VDA 39 R48 0Ω 27 22 2 (MSB) B13A **CDGNDA** GND GND 3 38 28 21 B12A C15 (LSB) D0A -013 - B0A (LSB) 113 4 37 B11A 5 R44, DNI B1A D1A _____ 20 10µF DGNDA 36 112 012 _3.3VDA 30 B10A 6 19 DUT_3.3VDA 35 vcc vcc (DUT B9A 31 DGNDA 7 34 D2A -B2A R45, 100Ω R46, 100Ω B3A 111 011 B8A 17 32 8 33 D3A 110 010 B7A DGNDA 33 16 DGNDA B6A 10 9 32 R5 E61 50Ω GND GND R15, 100Ω R14, 100Ω R13, 100Ω B5A R13, 100Ω B6A 31 D4A 34 19 09 11 30 E60 6 9E59 35 14 D5A 18 08 12 29 BUFLATA-DRAOUT-13 36 B5A B4A 13 D6A - B6A 07 28 17 R12, 100Ω B7A 12 37 D7A -14 16 **O**6 B3A <u>15</u> 27 DGNDA 30 39 38 GND -DGNDA R24, 100Ω ^^^ B8A 11 GND 26 B2A 16 10 25 B1A 17 D8A -15 05 R23, 100Ω R23, 100Ω B9A 40 9 24 D9A -04 (LSB) B0A 18 14 23 D3A 41 (DUT_3.3VDA) 41 D10A 42 8 DUT_3.3VDA vcc vcc F1A 19 22 7 F0A 20 B10A R22, 100Ω B11A D10A -13 03 D11A 43 21 6 12 02 DGNDA 44 R21, 100Ω 5 GND GND DGNDA 4 D12A -11 01 R19, 100Ω B13A (MSB) 46 3 (MSB) D13A -10 00 47 2 LE1 OE1 DGNDA> R7 50Ω 48 1 +LATCHA 74LCX16374 L_{0 E58} U7 24 DGNDB R11, DNI H40DN J2 R49 0Ω LE2 OE2 25 F0B R10, DNI F1B ~ 115 015 23 26 R50 0Ω 40 014 114 3.3VDB 27 22 39 2 GND GND (MSB) B13B DGNDB 3 38 28 21 R29, DNI W B1B B12B -(LSB) D0B -013 C14 113 4 37 29 20 10µF B11B 1 012 D1B 112 5 6 36 DIB 30 VCC 31 VCC 19 DUT_3.3VDB B10B vcc Ċ 35 18 B9B DGNDB D2B -111 011 B2B R28, 100Ω B3B R27, 100Ω 7 34 B8B 32 17 8 33 D3B -110 010 B7B 16 DGNDB DGNDB 33 9 32 GND GND $E64 \begin{array}{c} R2 \\ 50\Omega \end{array} \begin{array}{c} B6B \\ \hline 10 \\ \hline \end{array}$
 R26, 100Ω
 B4B

 R12, 100Ω
 B4B

 R9, 100Ω
 B6B

 R25, 100Ω
 B7B
 31 34 BUFLATB Ee30-Ee5 D4B -09 19 D5B 35 11 30 14 18 08 29 B5B 12 13 36 13 D6B -17 07 28 B4B 10 D7B <u>37</u> 12 16 06 27 B3B 15 DGNDB 38 GND GND 11 -DGNDB R36, 1000 R35, 1000 B8B R35, 1000 B9B 26 B2B 16 39 10 25 D8B -15 05 B1B 17 D9B _____40 9 (LSB) B0B 11 18 24 14 04 DUT_3.3VDB 41 8 F1B 19 23 DUT_3.3VDB VCC VCC 22 7 B10B R34, 100Ω B11B F0B D10B -13 О3 20 21 43 6 DGNDB D11B -12 02 R33, 100Ω DGNDB 44 5 GND GND DGNDB ¹45 4 R31, 1000 R31, 1000 B13B (MSB) D12B -01 11 3 46 (MSB) D13B -10 00 47 2 OE1 LE1 DGNDB> 48 1 R8 ^{50Ω} ₩₩**-Ң-LATCHB** 74LCX16374 _0 E57

Figure 10b. Evaluation Board

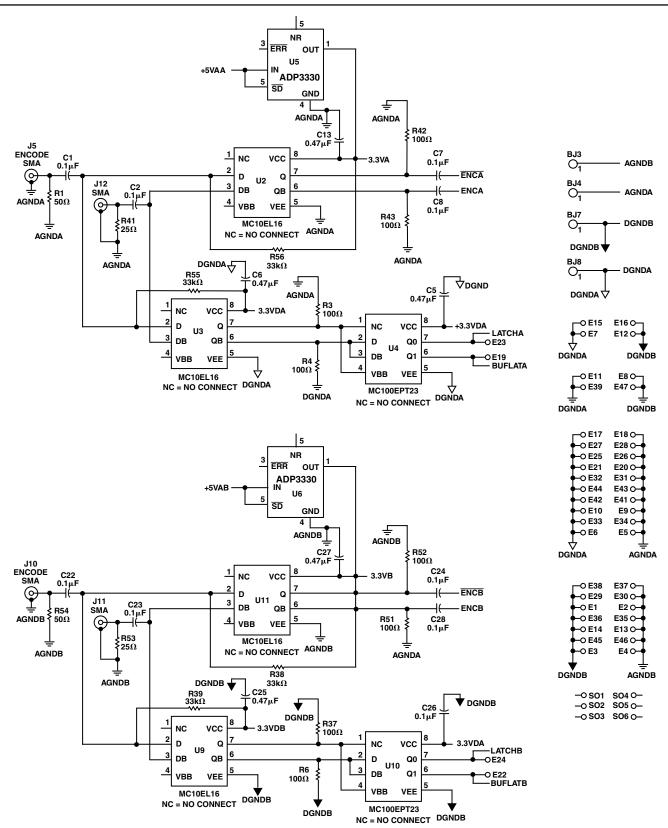


Figure 10c. Evaluation Board

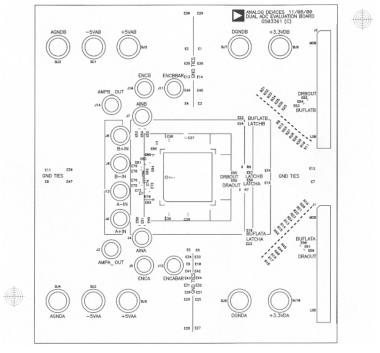


Figure 11a. Top Silk

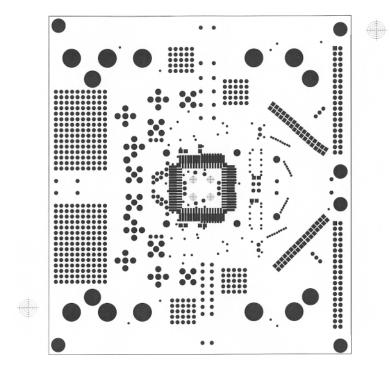


Figure 11b. Top Layer

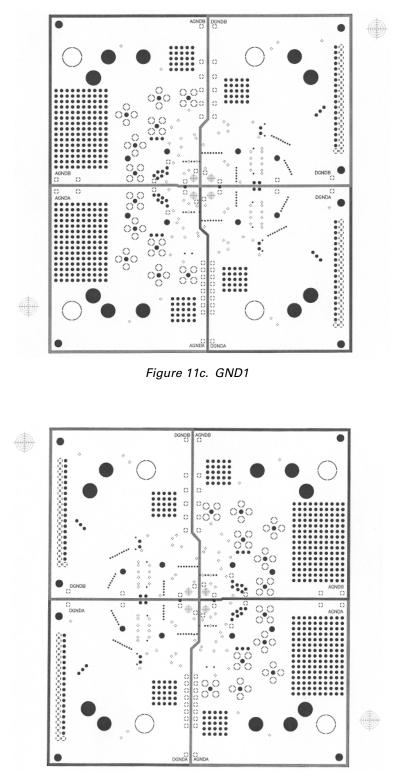


Figure 11d. GND2

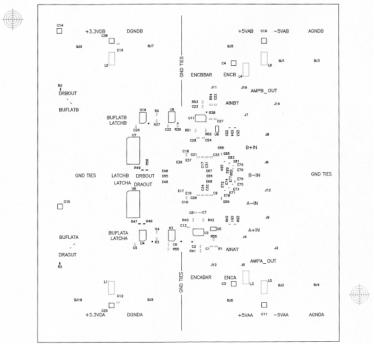


Figure 11e. Bottom Silk

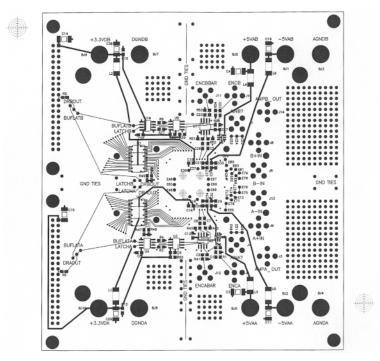
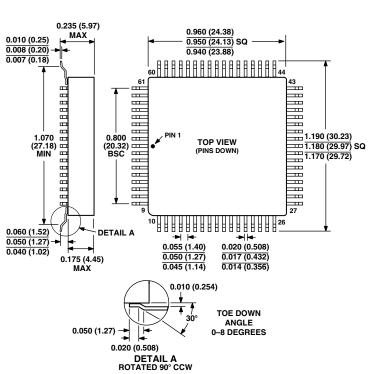


Figure 11f. Bottom Layer

OUTLINE DIMENSIONS

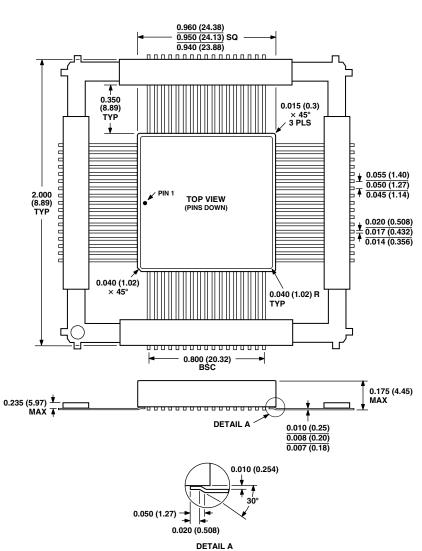
Dimensions shown in inches and (mm).



68-Lead Ceramic Leaded Chip Carrier (ES-68C)

OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).



68-Lead Ceramic Leaded Chip Carrier with Nonconductive Tie-Bar (ES-68C)